

May 2009 UniFETTM

FDL100N50F

N-Channel MOSFET,FRFET 500V, 100A, 0.055Ω

Features

- $R_{DS(on)}$ = 0.043 Ω (Typ.)@ V_{GS} = 10V, I_D = 50A
- Low gate charge (Typ. 238nC)
- Low Crss (Typ. 64pF)
- · Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant

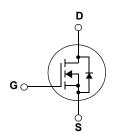


Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol		Parameter		FDL100N50F	Units
V _{DSS}	Drain to Source Voltage			500	V
V_{GSS}	Gate to Source Voltage	Gate to Source Voltage			V
	Drain Current	-Continuous (T _C = 25°C)		100	А
ID	Drain Current	-Continuous (T _C = 100°C)		60	A
I _{DM}	Drain Current	- Pulsed	400	Α	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)			5000	mJ
I _{AR}	Avalanche Current (Note 1		(Note 1)	100	Α
E _{AR}	Repetitive Avalanche Energy (Note 1)			73.5	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	20	V/ns
D	Dower Discipation	(T _C = 25°C)		2500	W
P_{D}	Power Dissipation	- Derate above 25°C		20	W/°C
T _J , T _{STG}	Operating and Storage Tempera	rating and Storage Temperature Range			°C
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	Min.	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	-	0.05	
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ.	0.1	-	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	-	30	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDL100N50F	FDL100N50F	TO-264	-	-	30

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	eteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$, $V_{GS} = 0 V$, $T_C = 25 ^{\circ} C$	500	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.5	-	V/°C
1	Zero Gate Voltage Drain Current	V _{DS} = 500V, V _{GS} = 0V	-	-	10	
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 400V, T_C = 125^{\circ}C$	10	100	μΑ	
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10V, I _D = 50A	-	0.043	0.055	Ω
g _{FS}	Forward Transconductance	$V_{DS} = 20V, I_D = 50A$ (Note 4)	-	95	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 05V V 0V		12000	-	pF
Coss	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz	-	1700	-	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	-	64	-	pF
Q _{g(tot)}	Total Gate Charge at 10V	V 400V I 50A	-	238	-	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DD} = 400V, I_{D} = 50A$ $V_{GS} = 10V$	-	74	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	VGS = 10V	-	95	-	nC

Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	V 050V L 50A	-	63	-	ns
t _r	Turn-On Rise Time	$V_{DD} = 250V, I_{D} = 50A$ $R_{G} = 4.7\Omega$	-	186	-	ns
t _{d(off)}	Turn-Off Delay Time	R _G = 4.752	-	202	-	ns
t _f	Turn-Off Fall Time		-	105	-	ns

Drain-Source Diode Characteristics

I_S	Maximum Continuous Drain to Source Diode Forward Current		-	-	100	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	400	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _{SD} = 100A	-	-	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 100A	-	250	-	ns
Q_{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	1.5	-	nC

Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 1mH, I $_{AS}$ = 100A, V $_{DD}$ = 50V, R $_{G}$ = 25 Ω , Starting T $_{J}$ = 25°C
- 3. I $_{SD} \leq$ 100A, di/dt \leq 200A/µs, $V_{DD} \leq$ BV $_{DSS},$ Starting T $_{J}$ = 25°C
- 4. Pulse Test: Pulse width $\leq 300 \mu s, \ \text{Duty Cycle} \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

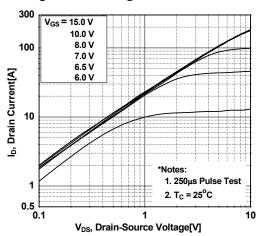


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

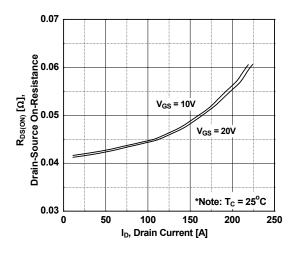


Figure 5. Capacitance Characteristics

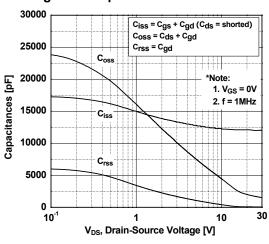


Figure 2. Transfer Characteristics

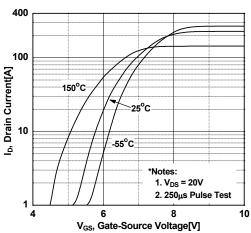


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

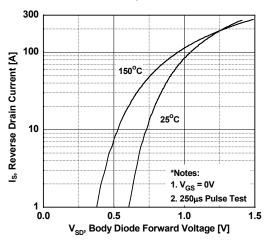
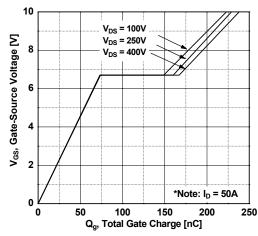


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

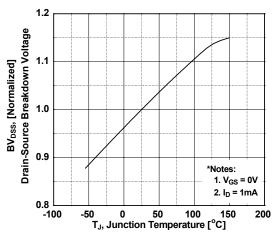


Figure 9. Maximum Safe Operating Area

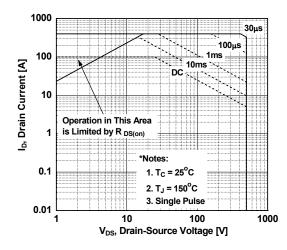


Figure 8. On-Resistance Variation vs. Temperature

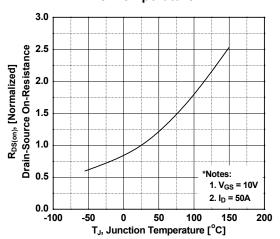


Figure 10. Maximum Drain Current vs. Case Temperature

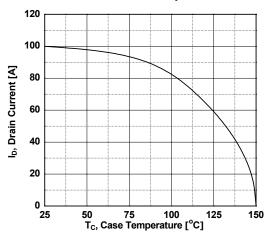
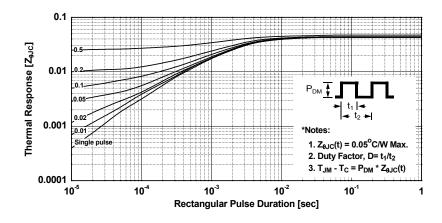
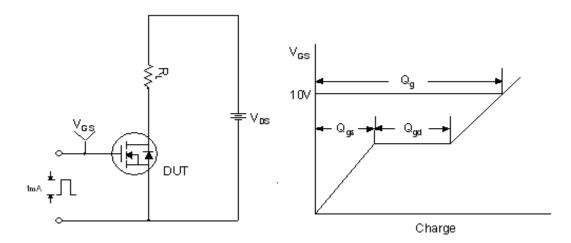


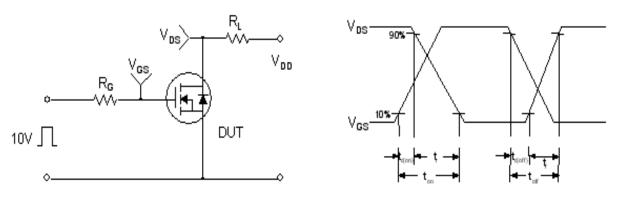
Figure 11. Transient Thermal Response Curve



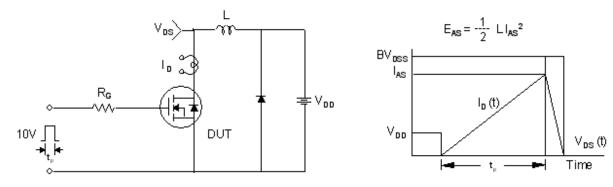
Gate Charge Test Circuit & Waveform



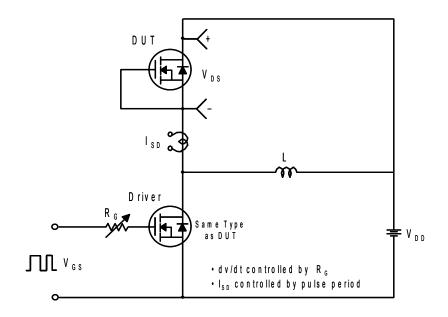
Resistive Switching Test Circuit & Waveforms

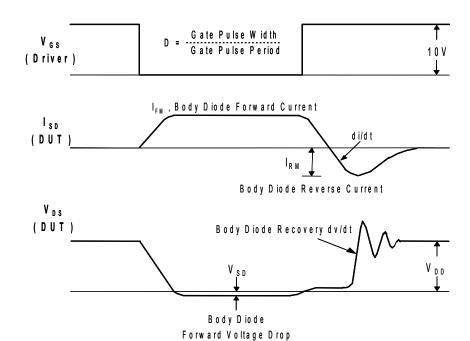


Unclamped Inductive Switching Test Circuit & Waveforms



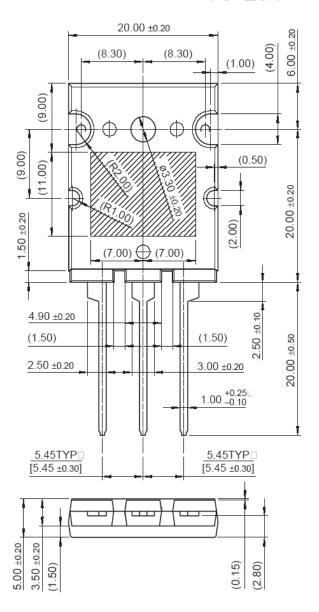
Peak Diode Recovery dv/dt Test Circuit & Waveforms

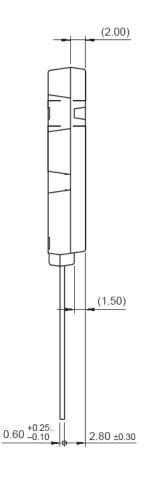




Mechanical Dimensions

TO-264





Dimensions in Millimeters





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